

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/720,539	<b>Applicant(s)/Patent under Reexamination</b> LEE, SEONG-HEE
	<b>Examiner</b> Kiet Doan	<b>Art Unit</b> 2617

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner